Mask Set Errata for Mask 1P02G

Revision History

This report applies to mask 1P02G for these products:

- MCXN947VDFT
- MCXN947VNL T
- MCXN946VDFT
- MCXN946VNL T
- MCXN546VDFT
- MCXN546VNL T
- MCXN547VDFT
- MCXN547VNL T

Table 1. Revision History

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<th>Date</th>
<th>Significant Changes</th>
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<td>0.1</td>
<td>1/2024</td>
<td>The following errata were added.</td>
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<td>• ERR052108</td>
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<td>• ERR051998</td>
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<td>• ERR050432</td>
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<td></td>
<td>• ERR051989</td>
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<tr>
<td>0.0</td>
<td>9/2023</td>
<td>Initial Revision</td>
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Errata and Information Summary

Table 2. Errata and Information Summary

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ERR051713: ADC: Extra conversion can occur when moving to low power mode

Description
When high-priority trigger exceptions are enabled (ADCx->CFG[HPT_EXDI] = 0x1) and the ADC command uses the "Repeat until true" compare option (ADCx->CMDHa[CMPEN] = 0x3), an extra conversion occurs at the end of the conversion cycle if a higher priority trigger is asserted when a low power request is also made. This can result in erroneous extra data in the result FIFO and/or prevent the ADC module from being disabled in the low power mode (even if the Doze enable bit is set - ADCx->CTRL[DOZEN] = 0x1).

Workaround
The ADC workaround is to do ONE of the following:
- Disable the ADC before entering low power mode (ADCx->CTRL[ADCEN] = 0)
- Disable high priority exceptions (ADCx->CFG[HPT_EXDI] = 0x1)
- If high priority exceptions are enabled (ADCx->CFG[HPT_EXDI] = 0x1) and "Repeat until true" compare option is used (ADCx->CMDHa[CMPEN] = 0x3), then the trigger command select (ADCx->TCTRLa[TCMD]) pointing to that command must be the highest priority (ADCx->TCTRLa[TPRI] = 0).
- User software waits for final conversion to be completed before entering low power mode.

ERR051051: Core: A partially completed VLLDM might leave Secure floating-point data unprotected

Description
Arm errata 2219175
Affects: Cortex-M33
Fault Type: Programmer Category B
Fault Status: Present in r0p0, r0p1, r0p2, r0p3, r0p4, r1p0. Open.

The VLLDM instruction allows Secure software to restore a floating-point context from memory. Due to this erratum, if this instruction is interrupted or it faults before it completes, then Secure data might be left unprotected in the floating point register file, including the FPSCR.

Configurations affected:
This erratum affects all configurations of the Cortex-M33 processor configured with the Armv8-M Security Extension and the Floating-point Extension.

Conditions:
This erratum occurs when all the following conditions are met:
• There is no active floating-point context, (CONTROL.FPCA==0)
• Secure lazy floating-point state preservation is not active, (FPCCR_S.LSPACT==0)
• The floating-point registers are treated as Secure (FPCCR_S.TS==1)
• Secure floating-point state needs to be restored, (CONTROL_S.SFPA == 1)
• Non-secure state is permitted to access to the floating-point registers, (NSACR.CP10 == 1)
• A VLLDM instruction has loaded at least one register from memory and does not complete due to an interrupt or fault
Implications:
If the floating-point registers contain Secure data, a VLSTM instruction is usually executed before calling a Non-secure function to protect the Secure data. This might cause the data to be transferred to memory (either directly by the VLSTM or indirectly by the triggering of a subsequent lazy state preservation operation). If the data has been transferred to memory, it is restored using VLLDM on return to Secure state. If the VLLDM is interrupted or it faults before it completes and enters a Non-secure handler, the partial register state which has been loaded will be accessible to Non-secure state.

Workaround
To avoid this erratum, software can ensure a floating-point context is active before executing the VLLDM instruction by performing the following sequence:

- Read CONTROL_S.SFPA
- If CONTROL_S.SFPA==1 then execute an instruction which has no functional effect apart from causing context creation (such as VMOV S0, S0)

ERR050505: Core: Access permission faults are prioritized over unaligned Device memory faults

Description
Cortex-M33 1080541-C:
A load or store which causes an unaligned access to Device memory will result in an UNALIGNED UsageFault exception. However, if the region is not accessible because of the MPU access permissions (as specified in MPU_RBAR.AP), then the resulting MemManage fault will be prioritized over the UsageFault.

Workaround
There is no workaround.
However, it is expected that no existing software is relying on this behavior since it was permitted in Armv7-M.

ERR050501: Core: DFSR.EXTERNAL is not set correctly when waking up from sleep

Description
Cortex-M33 1367266-C:
An external debug event which causes the processor to enter Debug state or the debug monitor should set DFSR.EXTERNAL. It has been found that this field is not set if the event occurs while the processor is asleep.

Workaround
There is no workaround.

ERR050502: Core: Execution priority might be wrong for one cycle after AIRCR is changed

Description
Cortex-M33 1435973-C:
AIRCR is used in the NVIC active tree to calculate the execution priority, which in turn is used to determine fault escalation, exception preemption, and other NVIC-related behaviors. When the active tree is pipelined and there are high latency IRQs active, there might be a glitch in the active tree output for one cycle after AIRCR is changed. The glitch results in NVIC producing wrong execution priority that is neither based on the old AIRCR value nor the new one.
Workaround
There is no workaround for this erratum.

ERR050500: Core: Group priority of a Non-secure interrupt might be incorrect when AIRCR.PRIS is set

Description
Cortex-M33 1113997-C:
When the processor is configured with Security extension and AIRCR.PRIS is 1, the Armv8-M architecture requires that the priorities of Non-secure interrupts are modified to ensure that Secure interrupts are prioritized over Non-secure interrupts. The Armv8-M architecture requires that lower priority numbers take precedence over higher priority numbers. Because of this erratum, a Non-secure interrupt with higher priority number might be handled in the wrong order compared to another Non-secure or Secure interrupt.

Workaround
There is no workaround for this erratum.

ERR050503: Core: Non-secure HardFault exception might preempt when disabled by AIRCR.BFHFNMINS

Description
Cortex-M33 1453380-C:
When the processor implements the Security Extension and AIRCR.BFHFNMINS is 1, the Non-secure banked version of SHCSR.HARDFAULTPENDED can be set to 1. This Non-secure pended HardFault might not preempt per architecture because it does not have enough priority (that is, the processor is in HardFault handler mode). If AIRCR.BFHFNMINS is subsequently changed to 0 with the Non-secure HardFault still pending, then the architecture requires that the Nonsecure HardFault should never preempt regardless of execution priority. Because of this erratum, the pended Non-secure HardFault exception preempts when AIRCR.BFHFNMINS is 0 and current execution priority is larger than -1 (Non-secure HardFault having higher priority).

Workaround
There is no workaround for this erratum.

ERR050504: Core: Sorting of pending interrupts might be wrong when high latency IRQs are pending

Description
Cortex-M33 1540599-C:
The NVIC contains a pending tree which sorts all pending and enabled interrupts based on priorities. If DHCSR.C_DEBUGEN and DHCSR.C_MASKINTS are 1, DHCSR.S_SDE is 0 and halting debug is allowed, then Nonsecure PendSV, Non-secure SysTick, and Non-secure IRQs should be masked off and they should not affect the sorting of pending and enabled secure interrupts. If multiple high latency IRQs are pending and enabled with different security targets and priorities, then Non-secure IRQs which should be masked off might cause the pending tree output to be a pending Secure interrupt without highest priority. This is because of incorrect masking before doing priority comparisons in the tree.

Workaround
There is no workaround for this erratum.
ERR050875: CoreSight: AHB-AP can issue transactions where HADDR[1:0] is not aligned to HSIZE on the AHB

Description
ARM errata 1624041
This erratum affects the following components:
• AHB Access Port.
The ARM Debug Interface v5 Architecture Specification specifies a TAR (Transfer Address Register) in the MEM-AP that holds the memory address to be accessed.
TAR[1:0] is used to drive HADDR[1:0] when accesses are made using the Data Read/Write register DRW.
When the AHB-AP is programmed to perform a word or half-word sized transaction the AHB-AP does not force HADDR[1:0] to be aligned to the access size. This can result in illegal AHB transactions that are not correctly aligned according to HSIZE if HADDR[1:0] is programmed with an unaligned value.
Conditions:
1) TAR[1:0] programmed with a value that is not aligned with the size programmed in the CSW register of the AHB-AP.
2) An access is initiated by an access to the Data Read/Write Register (DRW) in the AHB-AP.
Implications:
As a result of the programming conditions listed above, AHB-AP erroneously initiates an access on the AHB with HADDR[1:0] not aligned to the size on HSIZE. This might initiate an illegal AHB access.
Workaround
TAR[1:0] must be b00 for word accesses, TAR[0] must be b0 for half-word accesses.
Software program should program TAR with an address value that is aligned to transaction size being made.

ERR051704: DCDC: Failure changing to Low drive-strength mode

Description
The DCDC output may fail when transitioning from Normal to Low drive-strength, resulting in the DCDC output voltage dropping to the point it is not able to adequately power the VDD_CORE supply, or causes temporary brown-out conditions. This failure may occur when both of these conditions occur:
1) The transition from Normal drive strength (DCDC_VDD_DS = 10b) to Low drive-strength (DCDC_VDD_DS = 01b) occurs when the DCDC is actively switching the output.
2) The voltage level set in the bitfield SPC->LP_CFG[DCDC_VDD_LVL] is greater than or equal to the current output voltage of the DCDC.

Because this failure requires a specific timing to manifest, it may fail very infrequently in an application. The greater the load current of the DCDC, the more likely the failure will occur because the DCDC will spend more time in the active switching period. A higher rate of transitioning to Low drive-strength will also see a higher failure rate.

There are two scenarios when the DCDC drive-strength can transition from Normal to Low drive-strength, and this failure may occur:
1) While the MCU is in Active power mode, and the application changes the drive-strength setting by writing 01b to the bitfield SPC->ACTIVE_CFG[DCDC_VDD_DS]. Writing this bitfield will start the transition to Low drive-strength.
2) When the MCU enters a low-power mode (Deep Sleep, Power Down, or Deep Power Down), and Active mode uses Normal drive-strength with ACTIVE_CFG[DCDC_VDD_DS] = 10b, while the low-power mode uses Low drive-strength with LP_CFG[DCDC_VDD_DS] = 01b.
Workaround
This issue will always be avoided when the voltage level at the low-power low drive-strength is lower than the current output voltage of the DCDC. Before transitioning to Low drive-strength, ensure the voltage level in LP_CFG[DCDC_VDD_LVL] is lower than the voltage level in Normal drive-strength configured by ACTIVE_CFG[DCDC_VDD_LVL]. As part of this workaround, the voltage level used in Low drive-strength configured by LP_CFG[DCDC_VDD_LVL] must not be set to the maximum value 11b for 1.2 V at any time in an application.

If the desired voltage level in LP_CFG[DCDC_VDD_LVL] is the same as the level currently set in ACTIVE_CFG[DCDC_VDD_LVL], a workaround is to temporarily increase the voltage level in ACTIVE_CFG[DCDC_VDD_LVL], and then transition to Low drive-strength with the lower level in LP_CFG[DCDC_VDD_LVL]. Here is the sequence for this workaround:

1) Ensure LP_CFG is configured for Low drive-strength and the desired voltage level in Low drive-strength mode
2) Wait for the SPC bit SC[BUSY] to be clear.
3) Write ACTIVE_CFG[DCDC_VDD_LVL] with the value for the voltage level one step higher than the desired level in LP_CFG[DCDC_VDD_LVL].
4) Start the transition to Low drive-strength

If the workaround sequence above is used when the MCU enters a low-power mode, then when the MCU wakes the DCDC will return to Normal drive-strength with the output voltage level configured in SPC->ACTIVE_CFG[DCDC_VDD_LVL]. If a lower voltage level is preferred, the application can lower DCDC voltage by waiting for the bit SC[BUSY] to be clear and writing the new voltage level to SPC->ACTIVE_CFG[DCDC_VDD_LVL].

ERR051703: ENC: Compare interrupt generation persists when position counter equals to compare value

Description
When CTRL[CMPIE] is set and the position counter (LPOS and UPOS) matches COMP compare registers (LCOMP and UCOMP), the corresponding compare interrupt is constantly generated as long as the QDC counter value is equal to COMP, even if SW clears the interrupt flags.

Workaround
Keep CTRL[CMPIE] cleared and route the POS_MATCH signal using INPUTMUX to another module to either post-process the signal or to trigger a different interrupt. When the position counter equals COMP, POS_MATCH is asserted. You can use INPUTMUX to send the POS_MATCH trigger to a number of trigger inputs, the most typical use would be to route to CTIMER or SCTIMER to trigger a timer measurement which can be used to measure the time between POS_MATCH pulses. Alternatively, these same timers can be configured to interrupt immediately after 1 count, giving an interrupt 1 timer count after compare register matches.

ERR051204: ENET: MAC Unable to Identify PTP SYNC and Follow_Up Messages with Peer Delay Reserved Multicast Address in the 802.1AS Mixed Mode Operation

Description
This defect occurs only when the Ethernet MAC is configured for IEEE 802.1AS mixed mode. That is, when:

MAC_TIMESTAMP_CONTROL[AV8021ASMEN] = 1'b1

and

MAC_TIMESTAMP_CONTROL[SNAPTYPSEL] = 2'b01 and MAC_TIMESTAMP_CONTROL[TSEVNTENA] = 1'b0.

or
MAC_TIMESTAMP_CONTROL[SNAPTYPSEL]= 2'b01, MAC_TIMESTAMP_CONTROL[TSMSTREN] = 1'b0, and
MAC_TIMESTAMP_CONTROL[TSEVNTENA]= 1'b1.

the Ethernet MAC is unable to capture the ingress timestamp for PTP SYNC and Follow_Up messages that are received with PTP
Peer Delay Reserved multicast destination address. The slave node is unable to compute and perform the time correction, and
this results in inaccuracies in the maintained system time.

Workaround
The IEEE 802.1AS mixed mode is not a general use case. The time correction can be performed by using either Delay
Request-Response or Peer Delay mechanism. However, if mixed mode is required the application must program the
MAC_TIMESTAMP_CONTROL[TSENALL] = 1'b1, to enable the MAC to capture the timestamp for all the received packets. The
software must identify the PTP SYNC and Follow_Up messages and associate the timestamp status provided by the MAC.

ERR051993: FLASH: Flash fails to become ready during asynchronous interrupt event

Description
The flash can fail to become ready on an asynchronous interrupt event resulting in the SOC stalling and the CPU unable to
continue code execution.

This condition occurs when the Flash Doze bit is disabled (CMC0->FLASHCR[FLASHDOZE] = 0) and an asynchronous interrupt
event occurs when the flash is attempting to move to low power mode due to a WFI / WFE instruction execution.

Workaround
This issue has one workaround:
1) When moving to low power mode, ensure that the Flash Doze bit is set (CMC0->FLASHCR[FLASHDOZE] = 1).

Note that in implementing this workaround, bus masters that can operate during low power modes (such as the DMA engines) will
not be able to access the flash.

ERR052122: I3C : Data size limitation in Message mode DDR transfer

Description
The message length in DDR message(DMA) mode is defined in MWMSG_DDR_CONTROL2 [9:0].LEN field. The 2 MSBs [9:8]
of this field has no effect on operation. Only [7:0] part of this field is taken as length in number of Half words. So, for max value of
3FF h in this field is taken as FF h (255) by hardware , consequently the maximum amount of actual data gets limited as per the
operation type. For Read operation the actual data size will be (255 - 2) = 253 half-words ( 506 bytes ) and for write operation it
is (255 -1 ) = 254 halfword ( 508 bytes )

Workaround
Application need to limit the data size for Write and Read operation in message(DMA) mode of DDR transfer. Configure
MWMSG_DDR_CONTROL2 [9:0].LEN = FF h, For Read frame data receive size will be 506 bytes and for Write frame data
transmit size will be 508 bytes for a single frame.

ERR051617: I3C: In I2C compatibility mode read transaction not terminating correctly

Description
The I3C module can operate in I2C compatibility mode to support I2C devices. However when operating in this mode, the end of
any read transaction may terminate with a repeated START followed by the STOP instead of only a STOP.
Workaround
In I2C compatibility mode, the use of no skew should be avoided and must set to MCONFIG[SKEW] = 1.

ERR051162: I3C: Slave reset not supported when I3C is in slave mode

Description
When operating in slave mode, the I3C module is unable to reliably detect a slave reset from an external master. As a result this feature is not supported on this device and should be disabled in application software.

Workaround
When I3C is operating in slave mode, the application must mask the slave reset interrupt by writing '1' to the SLVRST field in the I3C Slave Interrupt Clear (SINTCLR) register.

ERR051588: LPSPI:Reset transmit FIFO after FIFO underrun by LPSPI Slave.

Description
Transmit FIFO pointers are corrupted when a transmit FIFO underrun occurs (SR[TEF]) in slave mode.

Workaround
When clearing the transmit error flag (SR[TEF] = 0b1) following a transmit FIFO underrun, reset the transmit FIFO (CR[RTF] = 0b1) before writing any new data to the transmit FIFO.

ERR051629: LPUART:Transmit Complete bit (STAT[TC]) is not set.

Description
When the CTS pin is negated and the CTS feature is enabled (MODIR[TXCTSE] = 0b1) and the TX FIFO is flushed by software then, the Transmit Complete (STAT[TC]) flag is not set.

Workaround
Clear (MODIR[TXCTSE]) bit and reset the transmit FIFO (FIFO[TXFLUSH] = 0b1) when flushing the FIFO with CTS enabled (MODIR[TXCTSE] = 0b1).

ERR051705: NPX: Error when reading REMAP register

Description
Reading of the LIM data field (NPX0->REMAP[LIM]) returns incorrect results. Instead of returning the LIM field value, the LIM_DP field value is returned. Writes to the LIM data field are not affected.

Workaround
There is no workaround to this issue. Customer software should write the NPX0->REMAP[LIM] field and assume this write occurred correctly.
ERR051374: PWM fault may work abnormally when the fault signal is very narrow

Description
If the fault signal pulse width is narrower than a certain threshold, the protected PWM channels may generate a glitch, which occurs after the PWM channel outputs become inactive.

Workaround
(1) When FCTRL2[NOCOMB] = 0, FFILT[GSTR]= 0, and FFILT[FILT_PER]=0, pulse width of fault signals must be larger than 6 PWM clock periods, otherwise a glitch may be generated on the protected PWM channels.
(2) When FCTRL2[NOCOMB] = 0, FFILT[GSTR]= 1, and FFILT[FILT_PER]=0, pulse width of fault signals must be larger than 3 PWM clock periods, otherwise a glitch may be generated on the protected PWM channels.
(3) When FCTRL2[NOCOMB] = 0, FFILT[GSTR]= 1, and FFILT[FILT_PER] has non-zero values, pulse width of fault signals must be larger than FILT_PER*(FILT_CNT+3)+6 PWM clock periods, otherwise a glitch may be generated on the protected PWM channels.
(4) When FCTRL2[NOCOMB] = 0, FFILT[GSTR]= 0, and FFILT[FILT_PER] has non-zero values, pulse width of fault signals must be larger than FILT_PER*(FILT_CNT+3)+9 PWM clock periods, otherwise a glitch may be generated on the protected PWM channels.

ERR051989: PWM: output may be abnormal when the value of phase delay register is reduced from a non-zero value to 0.

Description
When the value of the SMxPHASEDLY register is reduced from a non-zero value to 0 and the SMxCTRL2[RELOAD_SEL]=1, the submodule x may output an unexpected wide PWM pulse (x=1,2,3).

Workaround
The minimum value of the SMxPHASEDLY register should be set as 1 in this process. To realize no phase delay between the submodule 0 and submodule x in this process, set the SMxPHASEDLY=1, SMxINIT=SM0INIT–1, SMxVALy=SM0VALy–1 (x=1,2,3, y=0,1,2,3,4,5).

ERR051689: PWM: Stretch count prescaler does not work properly

Description
PWM MCTRL2[STRETCH_CNT_PRSC] register bit field is intended to stretch the trigger pulse width to allow slower speed peripherals to capture the trigger. Due to this defect, however, this bit field is ineffective and output triggers are only able to be one clock width wide. This prevents the following peripherals from capturing PWM triggers:
- SCTIMER
- CTIMER
- CMP
- FlexIO
- SINC

Workaround
There is one workaround for this defect. The EVTG module can be used to stretch the PWM trigger pulse. To do this,
- Connect PWMa_SMb_MUX_TRIG0 to EVTG_AOI0_1 (INPUTMUX0[EVTG_TRIGx] = 0byy_yyy0, where x is the EVTG AOI input desired and 0byy_yyy0 is the Trig0 connection of the corresponding PWM instance and sub-module).
- Connect PWMa_SMb_MUX_TRIG1 to EVTG_AOI0_0 (INPUTMUX0[EVTG_TRIGx] = 0byy_yyy1, where x is the EVTG AOI input desired and 0byy_yyy1 is the Trig1 connection of the corresponding PWM instance and sub-module).
- Configure EVTG_OUT0A to the peripheral to be triggered in the INPUTMUX registers.
- Configure the EVTGx AOI to RS trigger mode (EVTGx[CTRL] = 0x4).
- Configure the EVTGx AOI_0 to pass the PWMa_SMb_MUX_TRIG1 signal directly. Configure all other signals to "Input Logic One".
- Configure the EVTGx AOI_1 engine to pass the PWMa_SMb_MUX_TRIG0 signal directly. Configure all other signals to "Input Logic One".
- Configure the PWMa[SMbTCTRL]->OUT_TRIG_EN bit field to route the TRIG0 and TRIG1 outputs to the desired VALz registers.

ERR051998: ROM: Command "get-property 12" not supported when using USB interface

Description
When using the USB interface to access the device in ISP mode, command "get-property 12" returns a fail result. This applies to both Full-Speed and High-Speed USB interfaces.

Workaround
There is no workaround for this issue. Customers should not use the "get-property 12" command when using USB as the ISP mode interface.

ERR052108: ROM: LDO_SYS VDD level not returned to Normal voltage range after programming fuses

Description
When programming any fuse using the ROM API, the voltage level of the LDO_SYS is not returned to Normal Voltage level (1.8V). That is, SPC0->ACTIVE_CFG[SYSLDO_VDD_LVL] = 1.

Workaround
User software should return the LDO_SYS voltage level to normal level immediately after programming fuses (SPC0->ACTIVE_CFG &^= SPC_ACTIVE_CFG_SYSLDO_VDD_LVL_MASK).
Note that the SDK functions which program fuses already account for this errata.

ERR051421: SAI: Synchronous mode with bypass is not supported

Description
The SAI does not receive or transmit when:

Scenario 1. The transmitter is configured for synchronous mode (TCR2[SYNC] = 0b1), in the Transmit Configuration 2 register, and the receiver is in bypass (RCR2[BYP]=0b1), in the Receiver Configuration 2 register, then there will not be a bit clock as it is the source of the BCLK.

Scenario 2. The receiver is configured for synchronous mode (RCR2[SYNC] = 0b1) in the Receiver Configuration 2 register and the transmitter is in bypass (TCR2[BYP]=0b1), in the Transmit Configuration 2 register, then there will not be a bit clock as it is the source of the BCLK.
Workaround
If scenario 1, then set the TCR2[BCI] = 0b1, in the Transmit Configuration 2 register.
If scenario 2, then set the RCR2[BCI] = 0b1, in the Receiver Configuration 2 register.

ERR051379: SRAM: Incorrect data reads when Auto-clock gating and ECC are enabled

Description
When Auto clock gating and ECC are both enabled for a given SRAM block, misaligned reads across block boundaries within that RAM block may return incorrect data.

Workaround
There are two workarounds for this errata:
1) If ECC and Auto-clock gating are required, ensure that misaligned accesses do not occur in your software
2) If either ECC or Auto-clock gating is not required, disable ECC or Auto-clock gating.

ERR050432: uSDHC: SD card initialization will fail after single block read without STOP CMD

Description
If a CMD with the response data size cannot be divided by 64 bytes, is given without a STOP CMD, and is followed by a software reset, SD card reinitialization will fail. Multi-block reads will not be affected as they are required to have a STOP CMD.

Workaround
Write 0b0 to the Data Transfer Direction Select bit (SDHC0->MIX_CONTROL[DTDSEL] = 0) before inserting a software reset.
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